IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants: Tamotsu NISHI et al.

Group Art Unit: Not Yet Assigned

Appl. No.

: 10/598,763

Examiner: Not Yet Assigned

(U.S. National Stage of PCT/JP2005/000396)

I.A. Filed

: January 14, 2005

Confirmation No.: 9405

For

: EQUIPMENT AND METHOD FOR REMOVING NITROGEN OXIDE

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
U.S. Patent and Trademark Office
Customer Service Window, Mail Stop <u>AMENDMENT</u>
Randolph Building
401 Dulany Street
Alexandria, VA 22314

Sir:

In accordance with the duty of disclosure under 37 C.F.R. §1.56 and §§1.97-1.98, Applicants hereby bring to the attention of the Examiner the following information.

The following documents were cited in an International Search Report with respect to International Patent Application No. PCT/JP2005/000396, of which the present application is the U.S. National Stage Application. A copy of the International Search Report (in English and Japanese) was been filed concurrently with the present application when entering the National Stage, and should thus have been brought to the attention of the Examiner.

- (1) Japanese Laid-Open Patent Publication No. 2001-129345 A, together with an English language Abstract thereof;
- (2) Japanese Laid-Open Patent Publication No. 2002-153724 A, together with an English language Abstract thereof;
- (3) Japanese Laid-Open Patent Publication No. SHO 53-077871 A, together with an English language Abstract thereof;
- (4) Japanese Laid-Open Patent Publication No. SHO 55-162331 A, together with an English language Abstract thereof;
- (5) Japanese Laid-Open Patent Publication No. 2002-253926 A, together with an English language Abstract thereof;
- (6) Japanese Laid-Open Patent Publication No. 2000-15058 A, together with an English language Abstract thereof;
- (7) Japanese Laid-Open Patent Publication No. HEI 9-253452 A, together with an English language Abstract thereof, and along with English language family member European Patent Publication No. EP 0 798 143 A1;
- (8) Japanese Laid-Open Patent Publication No. HEI 01-296000 A, together with an English language Abstract thereof;
- (9) Japanese Laid-Open Patent Publication No. HEI 11-262629 A, together with an English language Abstract thereof; and
- (10) Japanese Laid-Open Patent Publication No. SHO 51-148675 A, together with an English language Abstract thereof.

The relevance of the documents cited in the International Search Report, as ascertained with respect to the International claims by the International Examiner, is set forth in the International Search Report.

Applicants further bring to the attention of the Examiner the following documents:

- (11) Japanese Laid-Open Patent Publication No. HEI 10-211427 A, together with an English language Abstract of the same;
- (12) Japanese Laid-Open Patent Publication No. HEI 11-009957 A, together with an English language Abstract of the same; and
- (13) Japanese Laid-Open Patent Publication No. 2001-259798 A, together with an English language Abstract of the same.

Applicants note that above-noted documents (11) - (13) are cited on page 4 of the specification of the above-captioned application.

Applicants respectfully request that the Examiner consider the above material and cite the same. Copies of above-noted documents are attached hereto, and all of the above-noted documents are listed on an attached PTO-1449 Form. The Examiner is requested to initial the appropriate spaces on the attached Form and to return a copy of the completed Form to Applicants with the next official communication in the present application.

Applicant notes that an Office Action on the merits has not issued in the present application, and thus no fee is believed necessary to ensure consideration of the submitted material. However, if an Office Action on the merits has issued and is crossing this statement in the mail, the undersigned hereby authorizes the Commissioner to charge any fee {P28641 00098496.DOC}

necessary for the consideration of this statement, including any payment under 37 C.F.R. §1.17 (p) to Deposit Account No. 19-0089.

Should the Examiner have any questions, the Examiner is invited to contact the undersigned at the below-listed telephone number.

Respectfully submitted, Tamotsu NISHI et al.

Bruce H. Bernstein

Reg. No. 29,027

Stephen M. Roylance Reg. No. 31,296

January 8, 2007 GREENBLUM & BERNSTEIN, P.L.C. 1950 Roland Clarke Place Reston, Virginia 20191 (703) 716-1191 FORM PTO-1449

S. Department of Commerce Patent and Trademark Office

INFORMATION DISCLOSURE STATEMENT

BY APPLICANT (Use several sheets if necessary)

Atty. Docket P28641

Application No. 10/598,763

Sheet 1 of 1

Applicant

Tamotsu NISHI et al.

I.A. Filing Date January 14, 2005 Group
Not Yet Assigned

U.S. PATENT DOCUMENTS EXAMINER FILING DATE DATE INITIAL DOCUMENT NUMBER NAME **CLASS SUBCLASS** IF APPROPRIATE FOREIGN PATENT DOCUMENTS **TRANSLATION CLASS** DOCUMENT NUMBER DATE COUNTRY **SUBCLASS** YES 2001 2 9 3 4 05/15/01 **JAPAN** 5 2002 5 3 7 2 4 05/28/02 **JAPAN** 1 07/10/78 **JAPAN** 53 0 7 7 8 7 1 55 1 6 2 3 3 1 12/17/80 **JAPAN** 2 3 2 2002 5 9 6 09/10/02 **JAPAN** 5 0 1 0 5 01/18/00 2000 8 **JAPAN** 2 5 3 4 5 2 09/30/97 **JAPAN** 7 9 8 1 4 10/01/97 0 3 E.P.O. 1 2 9 0 0 0 11/29/89 **JAPAN** 6 2 2 2 09/28/99 11 6 6 **JAPAN** 51 1 7 5 4 8 6 12/12/76 **JAPAN** 2 2 10 4 08/11/98 **JAPAN** 0 11 9 9 5 7 01/19/99 **JAPAN** 2001 2 5 9 7 9 8 09/25/01 **JAPAN** OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.) English Language Abstract of JP 2001-129345. 1 2 English Language Abstract of JP 2002-153724. 3 English Language Abstract of JP 53-077871. English Language Abstract of JP 55-162331. 4 5 English Language Abstract of JP 2002-253926. 6 English Language Abstract of JP 2000-015058. 7 English Language Abstract of JP 9-253452.

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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12 13 English Language Abstract of JP 1-296000.

English Language Abstract of JP 11-262629. English Language Abstract of JP 51-148675.

English Language Abstract of JP 10-211247.
English Language Abstract of JP 11-009957.

English Language Abstract of JP 2001-259798.